

<b>Notice of References Cited</b>	Application/Control No. 10/685,031	Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Bruck Kifle, Ph.D.	Art Unit 1624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,552,013	04-2003	Audia et al.	514/212.04
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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